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## Listing of the Claims

 (Original) A method for constructing a wafer-interposer assembly comprising the steps of:

providing a wafer having a plurality of integrated circuit chips each having a plurality of contact pads; and

connecting the wafer to a wafer receiving portion of a wafer interposer to form a wafer-interposer assembly by electrical and non-temporary mechanical connection of at least some of the contact pads of the integrated circuit chips with contact pads of the wafer receiving portion, the wafer interposer having a handling portion extending outwardly from the wafer receiving portion.

- 2. (Original) The method as recited in claim 1 further comprising the step of magnetically accessing the wafer-interposer assembly via at least one magnet operably associated with the handling portion of the wafer interposer.
- 3. (Original) The method as recited in claim 1 further comprising the step of securably coupling to the wafer-interposer assembly via at least one locking member operably associated with the handling portion of the wafer interposer.

- 4. (Original) The method as recited in claim 1 further comprising the step of disposing at least one stiffening member within the handling portion of the wafer interposer.
- 5. (Original) The method as recited in claim 1 further comprising the step of moving the wafer-interposer assembly using a set of bearings in the handling portion of the wafer interposer.
- 6. (Original) The method as recited in claim 1 further comprising the step of disposing a cushioning member around at least part of the handling portion of the wafer interposer.
- 7. (Original) The method as recited in claim 1 further comprising the step of removably attaching a cover to the handling portion of the wafer interposer that extends across the wafer receiving portion.
- 8. (Original) The method as recited in claim 1 further comprising the step of testing the integrated circuit chips of the wafer without contacting the integrated circuit chips.

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providing a wafer having a plurality of integrated circuit chips each having a plurality of contact pads;

connecting the wafer to a wafer receiving portion of a wafer interposer to form a wafer-interposer assembly by electrical and non-temporary mechanical connection of at least some of the contact pads of the integrated circuit chips with contact pads of the wafer receiving portion; and

accessing a handling portion of the wafer interposer that is operably associated with the wafer receiving portion without contacting the wafer.

- 10. (Original) The method as recited in claim 9 wherein the step of accessing the handling portion of the wafer interposer without contacting the wafer further comprises accessing at least one slot operably associated with the handling portion of the wafer interposer.
- 11. (Original) The method as recited in claim 9 wherein the step of accessing the handling portion of the wafer interposer without contacting the wafer further comprises accessing at least one hole operably associated with the handling portion of the wafer interposer.

- 12. (Original) The method as recited in claim 9 wherein the step of accessing the handling portion of the wafer interposer without contacting the wafer further comprises accessing at least one receiving member operably associated with the handling portion of the wafer interposer.
- 13. (Original) The method as recited in claim 9 wherein the step of accessing the handling portion of the wafer interposer without contacting the wafer further comprises accessing at least one magnet operably associated with the handling portion of the wafer interposer.
- 14. (Original) The method as recited in claim 9 wherein the step of accessing the handling portion of the wafer interposer without contacting the wafer further comprises securably coupling to the wafer-interposer assembly via at least one locking member operably associated with the handling portion of the wafer interposer.
- 15. (Original) The method as recited in claim 9 further comprising the step of disposing at least one stiffening member within the handling portion of the wafer interposer.

- 16. (Original) The method as recited in claim 9 further comprising the step of moving the wafer-interposer assembly using a set of bearings in the handling portion of the wafer interposer.
- 17. (Original) The method as recited in claim 9 further comprising the step of disposing a cushioning member around at least part of the handling portion of the wafer interposer.
- 18. (Original) The method as recited in claim 9 further comprising the step of removably attaching a cover to the handling portion of the wafer interposer that extends across the wafer receiving portion.
- 19. (Original) The method as recited in claim 9 further comprising the step of testing the integrated circuit chips of the wafer without contacting the integrated circuit chips.

20. (Original) A method for constructing chip assemblies comprising the steps of:

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providing a wafer having a plurality of integrated circuit chips each having a plurality of contact pads;

connecting the wafer to a wafer receiving portion of a wafer interposer to form a wafer-interposer assembly by electrical and non-temporary mechanical connection of at least some of the contact pads of the integrated circuit chips with contact pads of the wafer receiving portion;

accessing a handling portion of the wafer interposer extends outwardly from the wafer receiving portion without contacting the wafer;

separating the handling portion of the wafer interposer from the wafer interposer; and

singulating the wafer-interposer assembly into a plurality of chip assemblies, each chip assembly including at least one of the integrated circuit chips and a portion of the wafer interposer.

21. (Original) The method as recited in claim 20 wherein the step of separating the handling portion occurs prior to the step of singulating the wafer-interposer assembly.

- 22. (Original) The method as recited in claim 20 wherein the step of separating the handling portion occurs substantially simultaneously with the step of singulating the wafer-interposer assembly.
- 23. (Original) The method as recited in claim 20 further comprising the step of mounting at least one of the chip assemblies on a substrate.
- 24. (Original) The method as recited in claim 20 wherein the step of accessing the handling portion of the wafer interposer without contacting the wafer further comprises accessing at least one slot operably associated with the handling portion of the wafer interposer.
- 25. (Original) The method as recited in claim 20 wherein the step of accessing the handling portion of the wafer interposer without contacting the wafer further comprises accessing at least one hole operably associated with the handling portion of the wafer interposer.

26. (Original) The method as recited in claim 20 wherein the step of accessing the handling portion of the wafer interposer without contacting the wafer further comprises accessing at least one receiving member operably associated with the handling portion of the wafer interposer.